

Inventor: Cem Basceri et al.

Title: Supercritical Fluid Technology for Cleaning Processing Chambers and Systems

Assignee: Micron Technology, Inc.

INFORMATION DISCLOSURE STATEMENT

References – See Attached Form PTO-1449

The attached form PTO-1449 is submitted in compliance with 37 CFR § 1.56. Copies of the cited art are included with the exception of U.S. patents and published U.S. applications (Official Gazette Notice: 05 August 2003). No admission is made regarding whether all the submitted references are prior art.

Respectfully submitted,

Dated: August 6, 2003 By: Jennifer J. Taylor
Jennifer J. Taylor, Ph.D.
Reg. No. 48,711

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE				ATTY. DOCKET NO. MI22-2233	SERIAL NO. Not yet assigned		
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT Cem Basceri et al.			
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